# 3.3V 2:1:9 Differential HSTL/PECL/LVDS to HSTL Clock Driver with LVTTL Clock Select and Enable

#### Description

The MC100EP809 is a low skew 2:1:9 differential clock driver, designed with clock distribution in mind, accepting two clock sources into an input multiplexer. The part is designed for use in low voltage applications which require a large number of outputs to drive precisely aligned low skew signals to their destination. The two clock inputs are one differential HSTL and one differential LVPECL. Both input pairs can accept LVDS levels. They are selected by the CLK\_SEL pin which is LVTTL. To avoid generation of a runt clock pulse when the device is enabled/disabled, the Output Enable (OE), which is LVTTL, is synchronous ensuring the outputs will only be enabled/disabled when they are already in LOW state (Figure 9).

The MC100EP809 guarantees low output–to–output skew. The optimal design, layout, and processing minimize skew within a device and from lot to lot. The MC100EP809 output structure uses open emitter architecture and will be terminated with 50  $\Omega$  to ground instead of a standard HSTL configuration (Figure 7). To ensure the tight skew specification is realized, both sides of the differential output need to be terminated identically into 50  $\Omega$  even if only one output is being used. If an output pair is unused, both outputs may be left open (unterminated) without affecting skew.

Designers can take advantage of the EP809's performance to distribute low skew clocks across the backplane of the board. Both clock inputs may be single—end driven by biasing the non–driven pin in an input pair (Figure 8).

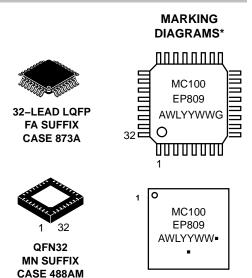
#### **Features**

- 100 ps Typical Device-to-Device Skew
- 15 ps Typical within Device Skew
- HSTL Compatible Outputs Drive 50  $\Omega$  to GND with no Offset Voltage
- Maximum Frequency > 750 MHz
- 850 ps Typical Propagation Delay
- Fully Compatible with Micrel SY89809L
- PECL and HSTL Mode Operating Range: V<sub>CCI</sub> = 3 V to 3.6 V with GND = 0 V, V<sub>CCO</sub> = 1.6 V to 2.0 V
- Open Input Default State
- These Devices are Pb-Free and are RoHS Compliant



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A = Assembly Location

WL = Wafer Lot YY = Year

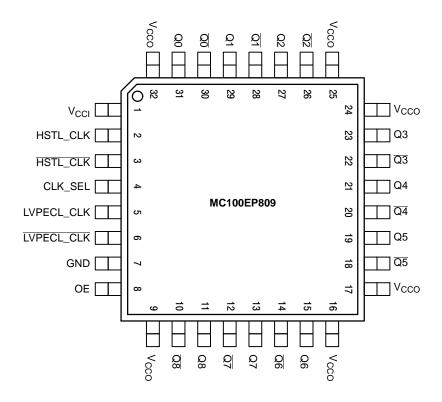
WW = Work Week
G or ■ = Pb-Free Package

(Note: Microdot may be in either location)

#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 8 of this data sheet.

<sup>\*</sup>For additional marking information, refer to Application Note AND8002/D.



All V<sub>CCI</sub>, V<sub>CCO</sub>, and GND pins must be externally connected to appropriate Power Supply to guarantee proper operation (V<sub>CCI</sub>  $\neq$  V<sub>CCO</sub>).

Figure 1. 32-Lead LQFP Pinout (Top View)

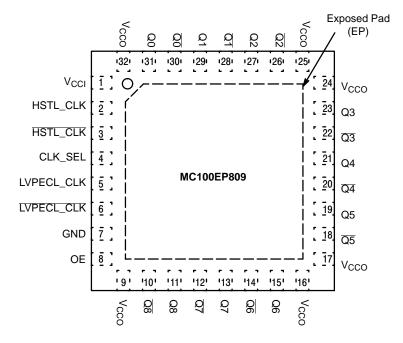


Figure 2. 32-Lead QFN Pinout (Top View)

**Table 1. PIN DESCRIPTION** 

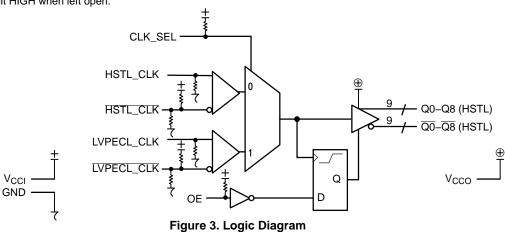
	_
PIN	FUNCTION
HSTL_CLK*, HSTL_CLK**	HSTL or LVDS Differential Inputs
LVPECL_CLK*, LVPECL_CLK**	LVPECL or LVDS Differential Inputs
CLK_SEL**	LVCMOS/LVTTL Input CLK Select
OE**	LVCMOS/LVTTL Output Enable
Q0 – Q8, Q0 – Q8	HSTL Differential Outputs
V <sub>CC1</sub>	Positive Supply_Core (3.0 V – 3.6 V)
V <sub>CC0</sub>	Positive Supply_HSTL Outputs (1.6 V – 2.0 V)
GND	Ground
EP	The exposed pad (EP) on the QFN–32 package bottom is thermally connected to the die for improved heat transfer out of the package. The exposed pad must be attached to a heat–sinking conduit. The pad is electrically connected to GND.

**Table 2. TRUTH TABLE** 

OE*	CLK_SEL	Q0 – Q8	Q0 – Q8
L	L	L	Н
L	Н	L	Н
Н	L	HSTL_CLK	HSTL_CLK
Н	Н	LVPECL_CLK	LVPECL_CLK

<sup>\*</sup>The OE (Output Enable) signal is synchronized with the rising edge of the HSTL\_CLK and LVOCL\_CLK signals.

<sup>\*</sup> Pins will default LOW when left open.
\*\* Pins will default HIGH when left open.



**Table 3. ATTRIBUTES** 

Charact	Value			
Internal Input Pulldown Resisto	75	kΩ		
Internal Input Pullup Resistor		37.5	5 kΩ	
ESD Protection	> 2 kV > 200 V > 2 kV			
Moisture Sensitivity, Indefinite	Fime Out of Drypack (Note 1)	Pb Pkg	Pb-Free Pkg	
	LQFP-32 QFN-32	Level 2 N/A	Level 2 Level 1	
Flammability Rating	UL 94 V-0	@ 0.125 in		
Transistor Count	478 D	evices		
Meets or exceeds JEDEC Spec	EIA/JESD78 IC Latchup Test			

1. For additional information, see Application Note AND8003/D.

**Table 4. MAXIMUM RATINGS** 

Symbol	Parameter	Condition 1	Condition 2	Rating	Unit
V <sub>CC1</sub>	Core Power Supply	GND = 0 V	V <sub>CC0</sub> = 1.6 to 2.0 V	4	V
V <sub>CC0</sub>	HSTL Output Power Supply	GND = 0 V	V <sub>CC1</sub> = 3.0 to 3.6 V	4	V
VI	Input Voltage	GND = 0 V	$V_{I} \leq V_{CC1}$	4	V
l <sub>out</sub>	Output Current	Continuous Surge		50 100	mA mA
T <sub>A</sub>	Operating Temperature Range			0 to +85	°C
T <sub>stg</sub>	Storage Temperature Range			-65 to +150	°C
$\theta_{\sf JA}$	Thermal Resistance (Junction-to-Ambient)	0 lfpm 500 lfpm	LQFP-32 LQFP-32	80 55	°C/W
$\theta_{\sf JC}$	Thermal Resistance (Junction-to-Case)	Standard Board	LQFP-32	12 to 17	°C/W
$\theta_{\sf JA}$	Thermal Resistance (Junction-to-Ambient)	0 lfpm 500 lfpm	QFN-32 QFN-32	31 27	°C/W
$\theta_{\sf JC}$	Thermal Resistance (Junction-to-Case)	2S2P	QFN-32	12	°C/W
T <sub>sol</sub>	Wave Solder Pb Pb-Free			265 265	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 5. LVPECL DC CHARACTERISTICS  $V_{CCI}$  = 3.0 V to 3.6 V;  $V_{CCO}$  = 1.6 V to 2.0 V, GND = 0 V

			0°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
I <sub>CC</sub>	Core Power Supply Current	75	95	115	75	95	115	75	95	115	mA
V <sub>IH</sub>	Input HIGH Voltage (Single-Ended)	V <sub>CCI</sub> – 1.165		V <sub>CCI</sub> – 0.88	V <sub>CCI</sub> – 1.165		V <sub>CCI</sub> – 0.88	V <sub>CCI</sub> – 1.165		V <sub>CCI</sub> – 0.88	V
V <sub>IL</sub>	Input LOW Voltage (Single-Ended)	V <sub>CCI</sub> – 1.945		V <sub>CCI</sub> – 1.6	V <sub>CCI</sub> – 1.945		V <sub>CCI</sub> – 1.6	V <sub>CCI</sub> – 1.945		V <sub>CCI</sub> – 1.6	V
VIHCMR	Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 2) (Figure 5) LVPECL_CLK/LVPECL_CLK	1.2		V <sub>CCI</sub>	1.2		V <sub>CCI</sub>	1.2		V <sub>CCI</sub>	٧
I <sub>IH</sub>	Input HIGH Current	-150		150	-150		150	-150		150	μΑ
I <sub>IL</sub>	Input LOW Current	-150		150	-150		150	-150		150	μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

<sup>2.</sup>  $V_{IHCMR}$  max varies 1:1 with  $V_{CCI}$ . The  $V_{IHCMR}$  range is referenced to the most positive side of the differential input signal.

Table 6. LVTTL/LVCMOS DC CHARACTERISTICS  $V_{CCI} = 3.0 \text{ V}$  to 3.6 V;  $V_{CCO} = 1.6 \text{ V}$  to 2.0 V, GND = 0 V

			0°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
V <sub>IH</sub>	Input HIGH Voltage	2.0			2.0			2.0			V
V <sub>IL</sub>	Input LOW Voltage			0.8			0.8			0.8	V
I <sub>IH</sub>	Input HIGH Current	-150		150	-150		150	-150		150	μΑ
I <sub>IL</sub>	Input LOW Current	-300		300	-300		300	-300		300	μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

Table 7. HSTL DC CHARACTERISTICS  $V_{CCI}$  = 3.0 V to 3.6 V;  $V_{CCO}$  = 1.6 V to 2.0 V, GND = 0 V

			0°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
V <sub>OH</sub>	Output HIGH Voltage (Note 3)	1.0		1.2	1.0		1.2	1.0		1.2	V
V <sub>OL</sub>	Output LOW Voltage (Note 3)	0.1		0.4	0.1		0.4	0.1		0.4	V
V <sub>IH</sub>	Input HIGH Voltage (Figure 6)	V <sub>X</sub> + 0.1		1.6	V <sub>X</sub> + 0.1		1.6	V <sub>X</sub> + 0.1		1.6	V
V <sub>IL</sub>	Input LOW Voltage (Figure 6)	-0.3		V <sub>X</sub> - 0.1	-0.3		V <sub>X</sub> – 0.1	-0.3		V <sub>X</sub> – 0.1	V
V <sub>X</sub>	HSTL Input Crossover Voltage	0.68	_	0.9	0.68	-	0.9	0.68	-	0.9	V
I <sub>IH</sub>	Input HIGH Current	-150		150	-150		150	-150		150	μΑ
I <sub>IL</sub>	Input LOW Current	-300		300	-300		300	-300		300	μΑ
V <sub>IHCMR</sub>	Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 4) HSTL_CLK/HSTL_CLK	0.6		V <sub>CCI</sub> - 1.2	0.6		V <sub>CCI</sub> – 1.2	0.6		V <sub>CCI</sub> – 1.2	V

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

<sup>3.</sup> All outputs loaded with 50  $\Omega$  to GND (Figure 7).

<sup>4.</sup>  $V_{IHCMR}$  max varies 1:1 with  $V_{CCI}$ . The  $V_{IHCMR}$  range is referenced to the most positive side of the differential input signal.

Table 8. AC CHARACTERISTICS  $V_{CCI} = 3.0 \text{ V}$  to 3.6 V;  $V_{CCO} = 1.6 \text{ V}$  to 2.0 V, GND = 0 V (Note 5)

			0°C			25°C			85°C		
Symbol	Characteristic	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
V <sub>Opp</sub>	$ \begin{array}{ccc} \text{Differential Output Voltage} & f_{\text{out}} < 100 \text{ MHz} \\ \text{(Figure 4)} & f_{\text{out}} < 500 \text{ MHz} \\ & f_{\text{out}} < 750 \text{ MHz} \end{array} $	600 600 450	850 750 575		600 600 450	850 750 575		600 600 450	850 750 575		mV mV
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay (Differential Configuration)  LVPECL_CLK to Q  HSTL_CLK to Q	680 690	800 830	930 990	700 700	820 850	950 1000	780 790	920 950	1070 1110	ps ps
t <sub>skew</sub>	Within–Device Skew (Note 6) Device–to–Device Skew (Note 7)		15 100	50 200		15 100	50 200		15 100	50 200	ps ps
t <sub>JITTER</sub>	Random Clock Jitter (Figure 4) (RMS)		1.4	3.0		1.4	3.0		1.4	3.0	ps
V <sub>PP</sub>	Input Swing (Differential Configuration) (Note 8) (Figure 5) LVPECL HSTL	200 200			200 200			200 200			mV mV
t <sub>S</sub>	OE Set Up Time (Note 9)	0.5			0.5			0.5			ns
t <sub>H</sub>	OE Hold Time	0.5			0.5			0.5			ns
t <sub>r</sub> /t <sub>f</sub>	Output Rise/Fall Time (20% – 80%)	350		600	350	450	600	350		600	ps

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

- 5. Measured with 750 mV (LVPECL) source or 1 V (HSTL) source, 50% duty cycle clock source. All outputs loaded with 50 Ω to GND (Figure 7).
- 6. Skew is measured between outputs under identical transitions and conditions on any one device.
- 7. Device-to-Device skew for identical transitions and conditions.
- 8. V<sub>PP</sub> is the Differential Input Voltage swing required to maintain AC characteristics listed herein.
- OE Set Up Time is defined with respect to the rising edge of the clock. OE High-to-Low transition ensures outputs remain disabled during the next clock cycle. OE Low-to-High transition enables normal operation of the next input clock (Figure 9).

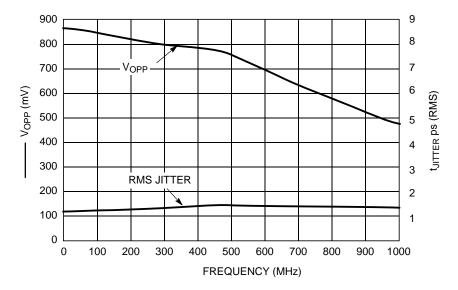


Figure 4. Output Frequency (F<sub>OUT</sub>) versus Output Voltage (V<sub>OPP</sub>) and Random Clock Jitter (t<sub>JITTER</sub>)



Figure 5. LVPECL Differential Input Levels

Figure 6. HSTL Differential Input Levels

 $V_{\text{CCO}}(\text{HSTL})$ 

 $\begin{aligned} & V_{IH}(DIFF) \\ & V_{X} \\ & V_{IL}(DIFF) \end{aligned}$ 

GND

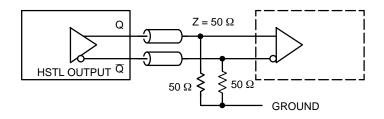
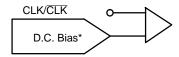


Figure 7. HSTL Output Termination and AC Test Reference



\*Must be CLK/ $\overline{\text{CLK}}$  common mode voltage: (( $V_{IH} + V_{IL}$ )/2).

Figure 8. Single-Ended CLK/CLK Input Configuration

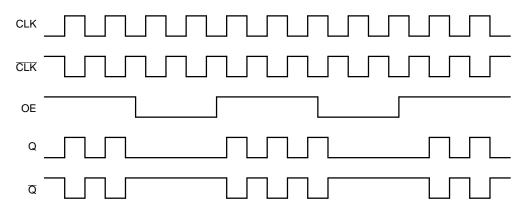


Figure 9. Output Enable (OE) Timing Diagram

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
MC100EP809FAG	LQFP-32 (Pb-Free)	250 Units / Tray
MC100EP809FAR2G	LQFP-32 (Pb-Free)	2000 / Tape & Reel
MC100EP809MNG	QFN32 (Pb-Free)	74 Units / Rail
MC100EP809MNR4G	QFN32 (Pb-Free)	1000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **Resource Reference of Application Notes**

AN1405/D - ECL Clock Distribution Techniques

AN1406/D - Designing with PECL (ECL at +5.0 V)

AN1503/D - ECLinPS™ I/O SPiCE Modeling Kit

AN1504/D - Metastability and the ECLinPS Family

AN1568/D - Interfacing Between LVDS and ECL

AN1672/D - The ECL Translator Guide
AND8001/D - Odd Number Counters Design

AND8002/D - Marking and Date Codes

AND8020/D - Termination of ECL Logic Devices

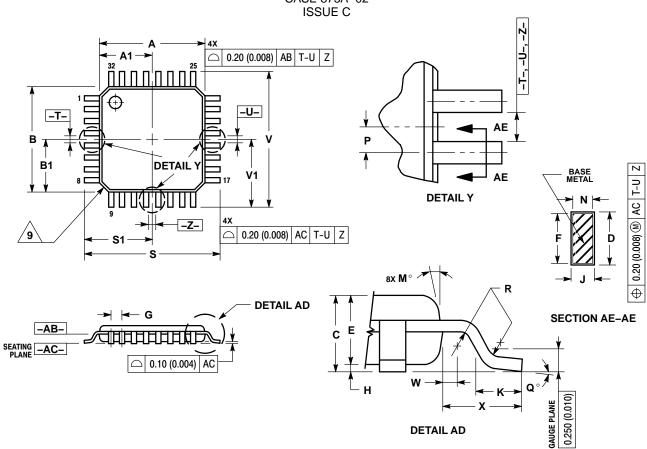
AND8066/D - Interfacing with ECLinPS

AND8090/D - AC Characteristics of ECL Devices

#### PACKAGE DIMENSIONS

#### 32 LEAD LQFP

CASE 873A-02



#### NOTES:

- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

  2. CONTROLLING DIMENSION: MILLIMETER.

  3. DATUM PLANE AB— IS LOCATED AT BOTTOM OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE BOTTOM OF THE PARTING LINE.

  4. DATUMS T–, U–, AND Z– TO BE DETERMINED AT DATUM PLANE AB—.

  5. DIMENSIONS S AND V TO BE DETERMINED AT SEATING PLANE AC–.

  6. DIMENSIONS A AND B DO NOT INCLUDE

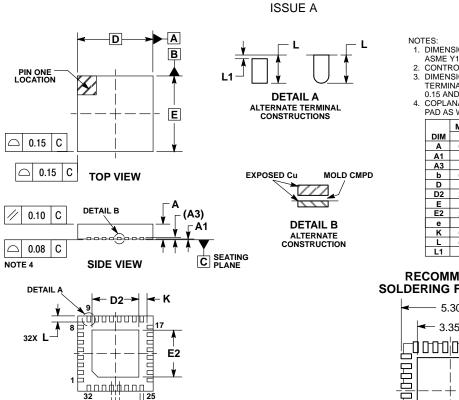
- DETERMINED AT SEATING PLANE -AC-.
  6. DIMENSIONS A AND B DO NOT INCLUDE
  MOLD PROTRUSION. ALLOWABLE
  PROTRUSION IS 0.250 (0.010) PER SIDE.
  DIMENSIONS A AND B DO INCLUDE
  MOLD MISMATCH AND ARE
  DETERMINED AT DATUM PLANE -AB-.
  7. DIMENSION D DOES NOT INCLUDE
  DAMBAR PROTRUSION. DAMBAR
  PROTRUSION SHALL NOT CAUSE THE
  D DIMENSION TO EXCEED 0.520 (0.020).
  8 MINIMUM SOI DER PLI ATE THICKNESS
- 8. MINIMUM SOLDER PLATE THICKNESS
- SHALL BE 0.0076 (0.0003).

  9. EXACT SHAPE OF EACH CORNER MAY VARY FROM DEPICTION.

	MILLIN	METERS	INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α	7.000	BSC	0.276	BSC	
A1	3.500	BSC	0.138	BSC	
В	7.000	BSC	0.276	BSC	
B1	3.500	BSC	0.138	BSC	
С	1.400	1.600	0.055	0.063	
D	0.300	0.450	0.012	0.018	
E	1.350	1.450	0.053	0.057	
F	0.300	0.400	0.012	0.016	
G	0.800	BSC	0.031	BSC	
Н	0.050	0.150	0.002	0.006	
J	0.090	0.200	0.004	0.008	
K	0.450	0.750	0.018	0.030	
M	12°	REF	12°	REF	
N	0.090	0.160	0.004	0.006	
P		BSC	0.016		
Q	1°	5°	1°	5 °	
R	0.150	0.250	0.006	0.010	
S	9.000	BSC	0.354	BSC	
S1	4.500	BSC	0.177 BSC		
٧	9.000	BSC	0.354 BSC		
V1	4.500	BSC	0.177	BSC	
W	0.200	REF	0.008	REF	
Х	1.000	) REF	0.039	REF	

#### PACKAGE DIMENSIONS

# QFN32 5x5, 0.5P CASE 488AM



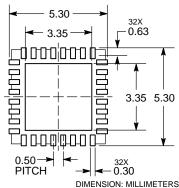
0.10 M C A B

0.05 M C NOTE 3

- DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994
- CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION 6 APPLIES TO PLATED
  TERMINAL AND IS MEASURED BETWEEN
  0.15 AND 0.30MM FROM THE TERMINAL TIP.
  COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	-	-
	MILLIM	ETERS
DIM	MIN	MAX
Α	0.80	1.00
A1		0.05
A3	0.20	REF
b	0.18	0.30
D	5.00	BSC
D2	2.95	3.25
Е	5.00	BSC
E2	2.95	3.25
е	0.50	BSC
K	0.20	
Ĺ	0.30	0.50
11		0.15

#### **RECOMMENDED SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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PI6C4931504-04LIE SI53305-B-GMR 83210AYLF NB6VQ572MMNG 4RCD0229KB1ATG PI6C4931502-04LIEX 8SLVD1212ANLGI
PI6C4931504-04LIEX AD9508BCPZ-REEL7 NBA3N200SDR2G 8T79S308NLGI SI53315-B-GMR NB7NQ621MMUTWG
49FCT3805DPYGI8 49FCT805BTPYG 49FCT805PYGI RS232-S5 542MILFT 6ES7390-1AF30-0AA0 74FCT3807PYGI SY89873LMG
SY89875UMG-TR 853S011BGILFT 853S9252BKILF 8P34S1102NLGI8 8T53S111NLGI CDCVF2505IDRQ1 CDCUA877ZQLT
CDCE913QPWRQ1 CDC2516DGGR 8SLVP2104ANBGI/W 8S73034AGILF LV5609LP-E 5T9950PFGI STCD2400F35F
74FCT3807QGI8 74FCT3807PYGI8